CMOS Digital Integrated Circuits Silicon Monolithic

TC74VHCV574FK

1. Functional Description

- Octal Schmitt D-Type Flip-Flop with 3-State Outputs

2. General

The TC74VHCV574FK is advanced high speed CMOS OCTAL FLIP-FLOP with 3-STATE OUTPUT fabricated with silicon gate CMOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

This 8-bit D-type flip-flop is controlled by a clock input (CK) and an output enable input ($\overline{OE}$).

When the $\overline{OE}$ input is high, the eight outputs are in a high impedance state.

Input pin have hysteresis between the positive-going and negative-going thresholds. Thus the TC74VHCV574FK is capable of squaring up transitions of slowly changing input signals and provides an improved noise immunity.

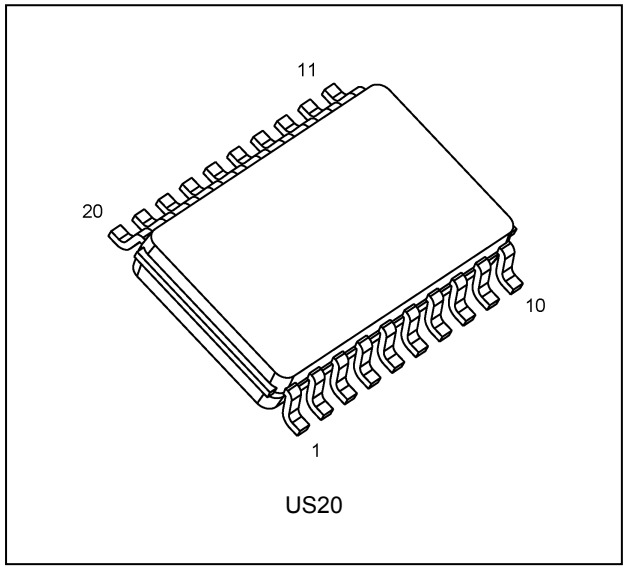
Input protection and output circuit ensure that 0 to 5.5 V can be applied to the input and output (Note) pins without regard to the supply voltage. These structure prevents device destruction due to mismatched supply and input/output voltages such as battery back up, etc.

Note: Output in off-state.

3. Features

(1) High speed: f_{MAX} = 180 MHz (typ.) at V_{CC} = 5.0 V
(2) Low power dissipation: I_{CC} = 2.0 μA (max) at T_a = 25 °C
(3) Wide operating voltage range: $V_{CC(opr)}$ = 1.8 V to 5.5 V
(4) Output current: $|I_{OH}|/I_{OL}$ = 16 mA (min)(V_{CC} = 4.5 V)
(5) Available in VSSOP (US)
(6) Power-down protection is provided on all inputs and outputs.
(7) Pin and function compatible with the 74 series (74AC/HC/AHC/LV etc.) 574 type.

4. Packaging

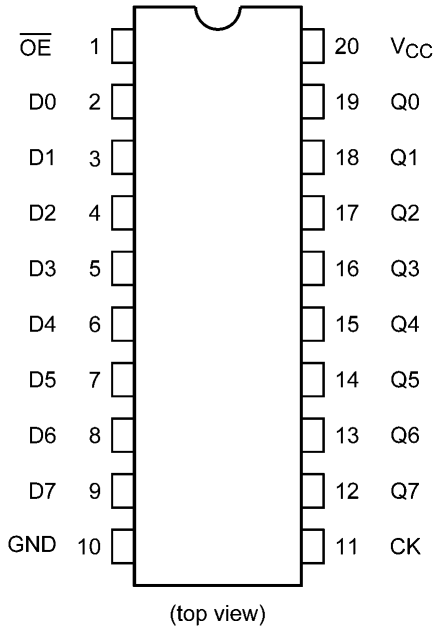


US20

Start of commercial production
2010-01

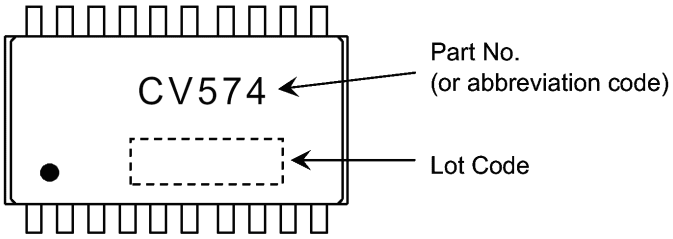
©2023
Toshiba Electronic Devices & Storage Corporation

5. Pin Assignment



(top view)

6. Marking



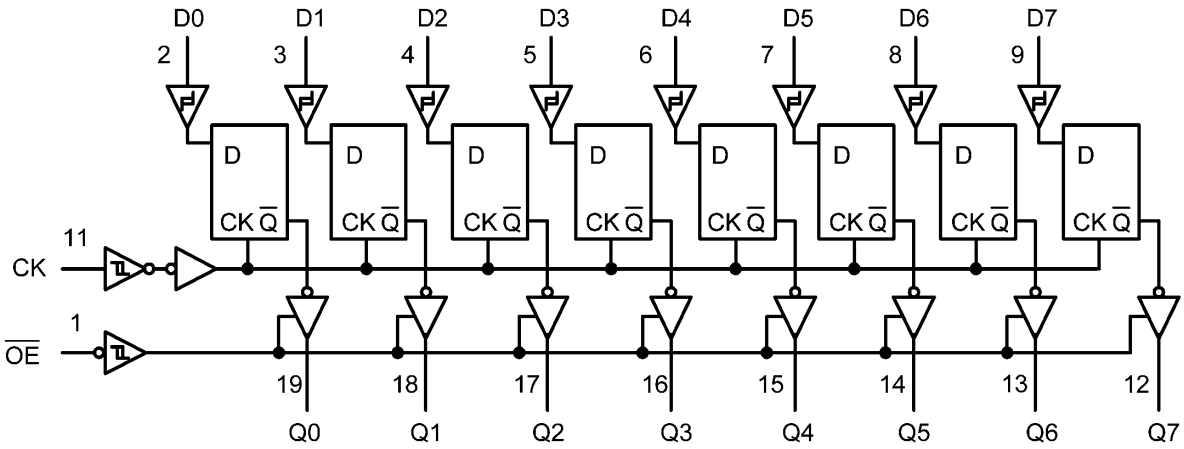
7. Truth Table

Inputs			Output
$\overline{OE}$	CK	D	
H	X	X	Z
L	↓	X	Qn
L	↑	L	L
L	↑	H	H

X: Don't care
Z: High impedance
Qn: No change

©2023
Toshiba Electronic Devices & Storage Corporation

8. System Diagram



©2023
Toshiba Electronic Devices & Storage Corporation

9. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V_{CC}		-0.5 to 7.0	V
Input voltage	V_{IN}		-0.5 to 7.0	V
Output voltage	V_{OUT}	(Note 1)	-0.5 to 7.0	V
		(Note 2)	-0.5 to V_{CC} + 0.5	
Input diode current	I_{IK}		-50	mA
Output diode current	I_{OK}	(Note 3)	±50	mA
Output current	I_{OUT}		±50	mA
Power dissipation	P_D		180	mW
V_{CC}/ground current	I_{CC}/I_{GND}		±100	mA
Storage temperature	T_{stg}		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook (“Handling Precautions”/“Derating Concept and Methods”) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Output in OFF state.

Note 2: High (H) or Low (L) state. I_{OUT} absolute maximum rating must be observed.

Note 3: V_{OUT} < GND, V_{OUT} > V_{CC}

10. Operating Ranges (Note)

Characteristics	Symbol	Test Condition	Note	Rating	Unit
Supply voltage	V_{CC}	—		1.8 to 5.5	V
Input voltage	V_{IN}	—		0 to 5.5	V
Output voltage	V_{OUT}	—	(Note 1)	0 to 5.5	V
			(Note 2)	0 to V_{CC}	
Operating temperature	T_{opr}	—		-40 to 85	°C
Input rise and fall times	dt/dv	V_{CC} = 3.3 ± 0.3 V		0 to 20	ms/V
		V_{CC} = 5 ± 0.5 V		0 to 1	

Note: The operating ranges must be maintained to ensure the normal operation of the device.
Unused inputs must be tied to either V_{CC} or GND.

Note 1: Output in OFF state.

Note 2: High (H) or Low (L) state.

©2023
Toshiba Electronic Devices & Storage Corporation

11. Electrical Characteristics

11.1. DC Characteristics (Unless otherwise specified, T_a = 25 °C)

Characteristics	Symbol	Test Condition		V_{CC} (V)	Min	Typ.	Max	Unit
Positive threshold voltage	V_P	—		1.8	—	—	1.65	V
				2.3	—	—	1.85	
				3.0	—	—	2.20	
				4.5	—	—	3.15	
				5.5	—	—	3.85	
Negative threshold voltage	V_N	—		1.8	0.15	—	—	V
				2.3	0.45	—	—	
				3.0	0.90	—	—	
				4.5	1.35	—	—	
				5.5	1.65	—	—	
Hysteresis voltage	V_H	—		1.8	0.15	—	1.05	V
				2.3	0.20	—	1.10	
				3.0	0.30	—	1.20	
				4.5	0.40	—	1.40	
				5.5	0.50	—	1.60	
High-level output voltage	V_{OH}	V_{IN} = V_{IH} or V_{IL}	I_{OH} = -50 μA	1.8	1.7	1.8	—	V
				3.0	2.9	3.0	—	
				4.5	4.4	4.5	—	
			I_{OH} = -8 mA	3.0	2.58	—	—	
			I_{OH} = -16 mA	4.5	3.94	—	—	
Low-level output voltage	V_{OL}	V_{IN} = V_{IH} or V_{IL}	I_{OL} = 50 μA	1.8	—	0.0	0.1	V
				3.0	—	0.0	0.1	
				4.5	—	0.0	0.1	
			I_{OL} = 8 mA	3.0	—	—	0.36	
			I_{OL} = 16 mA	4.5	—	—	0.44	
3-state output OFF-state leakage current	I_{OZ}	V_{IN} = V_{IH} or V_{IL} V_{OUT} = 0 to 5.5 V		1.8 to 5.5	—	—	±0.5	μA
Power-OFF leakage current	I_{OFF}	V_{IN}/V_{OUT} = 5.5 V		0	—	—	0.5	μA
Input leakage current	I_{IN}	V_{IN} = 5.5 V or GND		0 to 5.5	—	—	±0.1	μA
Quiescent supply current	I_{CC}	V_{IN} = V_{CC} or GND		5.5	—	—	2.0	μA

©2023
Toshiba Electronic Devices & Storage Corporation

11.2. DC Characteristics (Unless otherwise specified, T_a = -40 to 85 °C)

Characteristics	Symbol	Test Condition		V_{CC} (V)	Min	Max	Unit
Positive threshold voltage	V_P	—		1.8	—	1.65	V
				2.3	—	1.85	
				3.0	—	2.20	
				4.5	—	3.15	
				5.5	—	3.85	
Negative threshold voltage	V_N	—		1.8	0.15	—	V
				2.3	0.45	—	
				3.0	0.90	—	
				4.5	1.35	—	
				5.5	1.65	—	
Hysteresis voltage	V_H	—		1.8	0.15	1.05	V
				2.3	0.20	1.10	
				3.0	0.30	1.20	
				4.5	0.40	1.40	
				5.5	0.50	1.60	
High-level output voltage	V_{OH}	V_{IN} = V_{IH} or V_{IL}	I_{OH} = -50 μA	1.8	1.7	—	V
				3.0	2.9	—	
				4.5	4.4	—	
			I_{OH} = -8 mA	3.0	2.48	—	
			I_{OH} = -16 mA	4.5	3.80	—	
Low-level output voltage	V_{OL}	V_{IN} = V_{IH} or V_{IL}	I_{OL} = 50 μA	1.8	—	0.1	V
				3.0	—	0.1	
				4.5	—	0.1	
			I_{OL} = 8 mA	3.0	—	0.44	
			I_{OL} = 16 mA	4.5	—	0.55	
3-state output OFF-state leakage current	I_{OZ}	V_{IN} = V_{IH} or V_{IL} V_{OUT} = 0 to 5.5 V		1.8 to 5.5	—	±5.0	μA
Power-OFF leakage current	I_{OFF}	V_{IN}/V_{OUT} = 5.5 V		0	—	5.0	μA
Input leakage current	I_{IN}	V_{IN} = 5.5 V or GND		0 to 5.5	—	±1.0	μA
Quiescent supply current	I_{CC}	V_{IN} = V_{CC} or GND		5.5	—	20.0	μA

11.3. Timing Requirements (Unless otherwise specified, T_a = 25°C, Input: t_r = t_f = 3 ns)

Characteristics	Symbol	V_{CC} (V)	Limit	Unit
Minimum pulse width (CK)	$t_{w(L)}$,$t_{w(H)}$	2.5 ± 0.2	7.0	ns
		3.3 ± 0.3	5.0	
		5.0 ± 0.5	5.0	
Minimum setup time	t_s	2.5 ± 0.2	5.5	ns
		3.3 ± 0.3	3.5	
		5.0 ± 0.5	3.5	
Minimum hold time	t_h	2.5 ± 0.2	2.0	ns
		3.3 ± 0.3	1.5	
		5.0 ± 0.5	1.5	

©2023
Toshiba Electronic Devices & Storage Corporation

11.4. Timing Requirements (Unless otherwise specified, T_a = -40 to 85°C, Input: $t_r = t_f$ = 3 ns)

Characteristics	Symbol	V_{CC} (V)	Limit	Unit
Minimum pulse width (CK)	$t_{w(L)}$,$t_{w(H)}$	2.5 ± 0.2	7.0	ns
		3.3 ± 0.3	5.0	
		5.0 ± 0.5	5.0	
Minimum setup time	t_s	2.5 ± 0.2	5.5	ns
		3.3 ± 0.3	3.5	
		5.0 ± 0.5	3.5	
Minimum hold time	t_h	2.5 ± 0.2	2.0	ns
		3.3 ± 0.3	1.5	
		5.0 ± 0.5	1.5	

11.5. AC Characteristics (Unless otherwise specified, T_a = 25 °C, Input: $t_r = t_f$ = 3 ns)

Characteristics	Symbol	Note	Test Condition	V_{CC} (V)	C_L (pF)	Min	Typ.	Max	Unit
Propagation delay time (CK-Q)	t_{PLH},t_{PHL}		—	2.5 ± 0.2	15	—	9.1	16.6	ns
					50	—	11.9	19.6	
				3.3 ± 0.3	15	—	6.7	13.2	
					50	—	8.9	16.7	
				5.0 ± 0.5	15	—	5.0	8.6	
					50	—	6.7	10.6	
3-state output enable time	t_{PZL},t_{PZH}		R_L = 1 kΩ	2.5 ± 0.2	15	—	7.6	16.1	ns
					50	—	10.7	19.0	
				3.3 ± 0.3	15	—	5.7	12.8	
					50	—	8.1	16.3	
				5.0 ± 0.5	15	—	4.2	9.0	
					50	—	6.1	11.0	
3-state output disable time	t_{PLZ},t_{PHZ}		R_L = 1 kΩ	2.5 ± 0.2	50	—	13.6	17.5	ns
				3.3 ± 0.3	50	—	10.5	15.0	
				5.0 ± 0.5	50	—	8.2	10.1	
Maximum clock frequency	f_{MAX}		—	2.5 ± 0.2	15	60	95	—	MHz
					50	50	75	—	
				3.3 ± 0.3	15	80	135	—	
					50	55	100	—	
				5.0 ± 0.5	15	130	180	—	
					50	85	135	—	
Output skew	t_{osLH},t_{osHL}	(Note 1)	—	2.5 ± 0.2	50	—	—	2.0	ns
				3.3 ± 0.3	50	—	—	1.5	
				5.0 ± 0.5	50	—	—	1.0	ns
Input capacitance	C_{IN}		—			—	4	10	pF
Output capacitance	C_{OUT}		—			—	6	—	pF
Power dissipation capacitance	C_{PD}	(Note 2)	—			—	26	—	pF

Note 1: Parameter guaranteed by design. ($t_{osLH} = |t_{PLH}m - t_{PLH}n|$, $t_{osHL} = |t_{PHL}m - t_{PHL}n|$)

Note 2: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

$I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}/8$ (per latch)

And the total C_{PD} when n pcs. of latch operate can be gained by the following equation.

C_{PD} (total) = 14 + 12 × n

©2023
Toshiba Electronic Devices & Storage Corporation

11.6. AC Characteristics
(Unless otherwise specified, T_a = -40 to 85 °C, Input: $t_r = t_f$ = 3 ns)

Characteristics	Symbol	Note	Test Condition	V_{CC} (V)	C_L (pF)	Min	Max	Unit
Propagation delay time (CK-Q)	t_{PLH},t_{PHL}		—	2.5 ± 0.2	15	1.0	20.0	ns
					50	1.0	23.0	
				3.3 ± 0.3	15	1.0	15.5	
					50	1.0	19.0	
				5.0 ± 0.5	15	1.0	10.0	
					50	1.0	12.0	
3-state output enable time	t_{PZL},t_{PZH}		R_L = 1 kΩ	2.5 ± 0.2	15	1.0	19.0	ns
					50	1.0	22.0	
				3.3 ± 0.3	15	1.0	15.0	
					50	1.0	18.5	
				5.0 ± 0.5	15	1.0	10.5	
					50	1.0	12.5	
3-state output disable time	t_{PLZ},t_{PHZ}		R_L = 1 kΩ	2.5 ± 0.2	50	1.0	20.0	ns
				3.3 ± 0.3	50	1.0	17.0	
				5.0 ± 0.5	50	1.0	11.5	
Maximum clock frequency	f_{MAX}		—	2.5 ± 0.2	15	50	—	MHz
					50	40	—	
				3.3 ± 0.3	15	65	—	
					50	45	—	
				5.0 ± 0.5	15	110	—	
					50	75	—	
Output skew	t_{osLH},t_{osHL}	(Note 1)	—	2.5 ± 0.2	50	—	2.0	ns
				3.3 ± 0.3	50	—	1.5	
				5.0 ± 0.5	50	—	1.0	ns
Input capacitance	C_{IN}		—			—	10	pF

Note 1: Parameter guaranteed by design. ($t_{osLH} = |t_{PLHm} - t_{PLHn}|$, $t_{osHL} = |t_{PHLm} - t_{PHLn}|$)

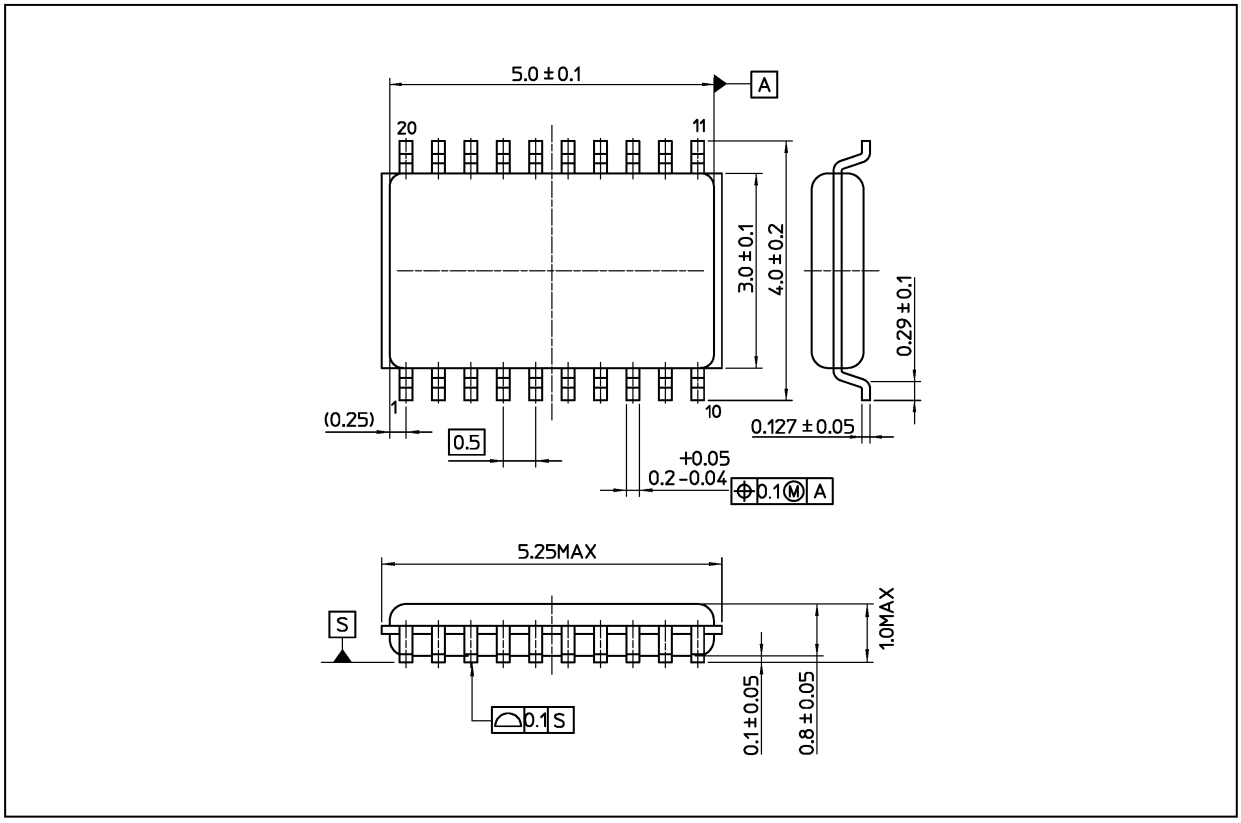
11.7. Noise Characteristics
(Unless otherwise specified, T_a = 25°C, Input: $t_r = t_f$ = 3 ns)

Characteristics	Symbol	Test Condition	V_{CC} (V)	Typ.	Max	Unit
Quiet output maximum dynamic V_{OL}	V_{OLP}	C_L = 50 pF	3.3	0.4	—	V
			5.0	0.8	—	
Quiet output minimum dynamic V_{OL}	V_{OLV}	C_L = 50 pF	3.3	-0.1	—	V
			5.0	-0.4	—	
Minimum high-level dynamic input voltage	V_{IHD}	C_L = 50 pF	5.0	—	3.5	V
Maximum low-level dynamic input voltage	V_{ILD}	C_L = 50 pF	5.0	—	1.5	V

©2023
Toshiba Electronic Devices & Storage Corporation

Package Dimensions

Unit: mm



Weight: 0.03 g (typ.)

Package Name(s)
Nickname: US20

RESTRICTIONS ON PRODUCT USE

Toshiba Corporation and its subsidiaries and affiliates are collectively referred to as "TOSHIBA".
Hardware, software and systems described in this document are collectively referred to as "Product".

- TOSHIBA reserves the right to make changes to the information in this document and related Product without notice.
- This document and any information herein may not be reproduced without prior written permission from TOSHIBA. Even with TOSHIBA's written permission, reproduction is permissible only if reproduction is without alteration/omission.
- Though TOSHIBA works continually to improve Product's quality and reliability, Product can malfunction or fail. Customers are responsible for complying with safety standards and for providing adequate designs and safeguards for their hardware, software and systems which minimize risk and avoid situations in which a malfunction or failure of Product could cause loss of human life, bodily injury or damage to property, including data loss or corruption. Before customers use the Product, create designs including the Product, or incorporate the Product into their own applications, customers must also refer to and comply with (a) the latest versions of all relevant TOSHIBA information, including without limitation, this document, the specifications, the data sheets and application notes for Product and the precautions and conditions set forth in the "TOSHIBA Semiconductor Reliability Handbook" and (b) the instructions for the application with which the Product will be used with or for. Customers are solely responsible for all aspects of their own product design or applications, including but not limited to (a) determining the appropriateness of the use of this Product in such design or applications; (b) evaluating and determining the applicability of any information contained in this document, or in charts, diagrams, programs, algorithms, sample application circuits, or any other referenced documents; and (c) validating all operating parameters for such designs and applications. **TOSHIBA ASSUMES NO LIABILITY FOR CUSTOMERS' PRODUCT DESIGN OR APPLICATIONS.**
- PRODUCT IS NEITHER INTENDED NOR WARRANTED FOR USE IN EQUIPMENTS OR SYSTEMS THAT REQUIRE EXTRAORDINARILY HIGH LEVELS OF QUALITY AND/OR RELIABILITY, AND/OR A MALFUNCTION OR FAILURE OF WHICH MAY CAUSE LOSS OF HUMAN LIFE, BODILY INJURY, SERIOUS PROPERTY DAMAGE AND/OR SERIOUS PUBLIC IMPACT ("UNINTENDED USE").
  Except for specific applications as expressly stated in this document, Unintended Use includes, without limitation, equipment used in nuclear facilities, equipment used in the aerospace industry, lifesaving and/or life supporting medical equipment, equipment used for automobiles, trains, ships and other transportation, traffic signaling equipment, equipment used to control combustions or explosions, safety devices, elevators and escalators, and devices related to power plant.
  IF YOU USE PRODUCT FOR UNINTENDED USE, TOSHIBA ASSUMES NO LIABILITY FOR PRODUCT.
  For details, please contact your TOSHIBA sales representative or contact us via our website.
- Do not disassemble, analyze, reverse-engineer, alter, modify, translate or copy Product, whether in whole or in part.
- Product shall not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable laws or regulations.
- The information contained herein is presented only as guidance for Product use. No responsibility is assumed by TOSHIBA for any infringement of patents or any other intellectual property rights of third parties that may result from the use of Product. No license to any intellectual property right is granted by this document, whether express or implied, by estoppel or otherwise.
- **ABSENT A WRITTEN SIGNED AGREEMENT, EXCEPT AS PROVIDED IN THE RELEVANT TERMS AND CONDITIONS OF SALE FOR PRODUCT, AND TO THE MAXIMUM EXTENT ALLOWABLE BY LAW, TOSHIBA (1) ASSUMES NO LIABILITY WHATSOEVER, INCLUDING WITHOUT LIMITATION, INDIRECT, CONSEQUENTIAL, SPECIAL, OR INCIDENTAL DAMAGES OR LOSS, INCLUDING WITHOUT LIMITATION, LOSS OF PROFITS, LOSS OF OPPORTUNITIES, BUSINESS INTERRUPTION AND LOSS OF DATA, AND (2) DISCLAIMS ANY AND ALL EXPRESS OR IMPLIED WARRANTIES AND CONDITIONS RELATED TO SALE, USE OF PRODUCT, OR INFORMATION, INCLUDING WARRANTIES OR CONDITIONS OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, ACCURACY OF INFORMATION, OR NONINFRINGEMENT.**
- Do not use or otherwise make available Product or related software or technology for any military purposes, including without limitation, for the design, development, use, stockpiling or manufacturing of nuclear, chemical, or biological weapons or missile technology products (mass destruction weapons). Product and related software and technology may be controlled under the applicable export laws and regulations including, without limitation, the Japanese Foreign Exchange and Foreign Trade Law and the U.S. Export Administration Regulations. Export and re-export of Product or related software or technology are strictly prohibited except in compliance with all applicable export laws and regulations.
- Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product. Please use Product in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. **TOSHIBA ASSUMES NO LIABILITY FOR DAMAGES OR LOSSES OCCURRING AS A RESULT OF NONCOMPLIANCE WITH APPLICABLE LAWS AND REGULATIONS.**

©2023
Toshiba Electronic Devices & Storage Corporation